Amendments to the Claims:

Please amend claims 1 and 6 and add new claim 7 as follows. The following listing of claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims:

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Claim 1 (Currently Amended). An X-ray diffraction apparatus in which:

- (a) said X-ray diffraction apparatus comprises an incident optical system, a sample support mechanism, a receiving optical system, and receiving-optical-system rotating means, and an X-ray emitted from the incident optical system is incident on a sample supported by the sample support mechanism, and an X-ray diffracted by the sample is detected by the receiving optical system;
- 10 (b) the receiving-optical-system rotating means has a function to rotate the receiving optical system around a first axis of rotation for changing an angle which is defined by a direction of the X-ray incident on the sample and an optical axis of the receiving optical system;

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- a multilayer-film mirror which has a function to collimate an X-ray emitted from the X-ray source within a plane perpendicular to the first axis of rotation;
- controlling means which has a function to switch a condition of the sample support mechanism from a state maintaining the sample to have a first attitude in which a normal line of the surface of the sample is substantially parallel with the first axis of rotation to another state maintaining the sample to have a second attitude in which the normal line of the surface of the sample is substantially perpendicular to the first axis of rotation;
 - (e) the sample support mechanism includes first incidentangle controlling means which has a function to rotate the sample
 around a second axis of rotation which is substantially
 perpendicular to the first axis of rotation for changing an
 incident angle of an X-ray which is emitted from the incident
 optical system and is incident on the surface of the sample in
 the first attitude; [[and]]
 - (f) the sample support mechanism includes second incidentangle controlling means which has a function to rotate the sample around the first axis of rotation for changing the incident angle

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of an X-ray which is emitted from the incident optical system and is incident on the surface of the sample in the second attitude; and

(g) the sample support mechanism includes a mechanism for rotating the sample around two axes of rotation which are orthogonal to each other and pass on the surface of the sample.

Claim 2 (Original). An apparatus according to Claim 1, wherein the attitude controlling means and the first incident-angle controlling means are actualized by a common mechanism.

Claim 3 (Original). An apparatus according to Claim 1, wherein the multilayer-film mirror includes a first reflection surface with a parabolic shape for collimating an X-ray within a first plane perpendicular to the first axis of rotation and a second reflection surface with a parabolic shape for collimating an X-ray on a second plane perpendicular to the first plane.

Claim 4 (Original). An apparatus according to Claim 1, wherein the multilayer-film mirror includes a first reflection surface with a parabolic shape for collimating an X-ray within a first plane perpendicular to the first axis of rotation and a

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5 second reflection surface with an elliptical-arc shape for focusing an X-ray on the sample within a second plane perpendicular to the first plane.

Claim 5 (Original). An apparatus according to Claim 1, wherein the receiving optical system can turn around the second axis of rotation too.

Claim 6 (Currently Amended). An apparatus according to Claim 1, wherein the sample support mechanism includes a mechanism for moving the sample in a direction perpendicular to the surface of the sample, a mechanism for translating the sample in a two-dimensional direction within a plane parallel with the surface of the sample, a mechanism for rotating the sample around two axes of rotation which are orthogonal to each other and pass on the surface of the sample, and a mechanism for an in-plane rotation of the sample.

Claim 7 (New). An apparatus according to Claim 1, wherein the attitude controlling means includes a curved guide having a circular-arc internal surface and an attitude-change table movable along the internal surface of the curved guide,

the curved guide has one end which is located at a position
higher than the sample and another end which is located at a position lower than the sample, and

a through-hole through which the X-ray can pass is formed in a vicinity of the one end of the curved guide.